

EMOS® VIEW

# **OVERVIEW**

Especially designed for the chlor-alkali and chlorate industry, EMOS® View is the application designed to monitor, manage and display process data obtained from the EMOS® SIL2 Safety System and its related tools such as the Pinhole Detector, Single Cell Temperature Evaluator or the Early Detection Engine. The convenient graphical interface is simple to read. Real-time events are easily identified, giving the operators the opportunity to react and adjust operations as needed.

Using these tools can help protect against :

- Anode coating loss
- Cathode coating loss
- Electrode passivation
- Membrane poisoning
- Insufficient electrolyte feed
- Cell temperature control failure
- Electrolyte concentration control failure
- Differential pressure out of range
- Cell leakage

0	k 🕆 🗘 🛱 👘 👩	Plant Overview	E1	E2	Status
Process	Catholyte concentratio				
Electrolyser	E1		E2		
LicculorySCI	CI				
Current	12.4 kA		9.3 kA		
Catholyte lemperalure	85.2 °C		85.1 °C		
Voltages Nin Avg Max	4.00	3.148 V	4.00	3.045	v
		lay		May	
	ed	3.083 V		2.978	v
		wq.	*	Avq	1997 C
		2.965 V		2.899	V
		in	2.00	Nn	
		0.004 V	0.03	0.012	v
		lax.		Max	
		0.005 V	⊲	-0.00	3 V
I I II Min Avg Max		vg	-4	- <b>U.UU</b> . Aug	
		0.077.14	4		
		0.033 V		-0.01	8 V
	58.0-		-0.03		
SCT Min Avg Max		86.7 °C	100.00	86.3	°C
	,	fex.		Max	
		35.2 °C		85.1	'C
	<b>V</b>	ing .	<	Aug	
		32.5 °C		83.6	c

HIGHLIGHTS	FEATURES		
Web based HMI for the EMOS® Safety System and	Status always visible with drill-down navigation		
its related tools such as: EMOS® SIL2 Safety System, Pinhole Detector, Single Cell Temperature Evaluator and the Early Detection Engine	Easy hierarchical navigation from the plant to the cell properties		
	Plant overview		
Real-time plant data monitoring	Electrolyzer view		
Real-time alarms and events	Configurable voltage trends (last 8, 12, 24 hours)		
Rear-time alarms and events	Cell properties value trends (last 8, 12, 24 hour configurable)		
Historical data analysis view	Real-time KPI monitoring		
	Easy print		
	Easy Excel snapshot		
Historical alarm analysis view	Advanced alarm analysis: see all tags that had contributed to the alarm event		



#### PRODUCT DATA SHEET

#### MKD0056 5V0 - EMOS View

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## **EMOS® VIEW**



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### SYSTEM REQUIREMENTS

EMOS® Server		EMOS® Monitoring Desktop client	
Operating System	Microsoft Windows Server 2022	Operating System	Microsoft Windows 7, Windows 10 and Windows 11, 64-bit
CPU	Intel® Xeon® processor	CPU	Intel® Core i5 6th generation (or an equivalent AMD processor) or above
RAM	16 GB	RAM	8 GB
Hard Drive	2x1TB RAID1 SSD (Solid State Drive) recommended	Hard Drive	500 GB SSD (Solid State Drive) recommended
Communication	OPC Link with DCS	Network Ports	(2) 100/1000
Network Ports	(4) 100/1000	Screen Resolution	1920 x 1080 (or better)

#### **AVAILABLE EXPANSION MODULES**

Part Number	Description	Part Number	Description
SW701	EMOS <sup>®</sup> Pinhole Detector	SWSTD	EMOS® Safety Software Package (includes EMOS® Monitoring w/ EMOS® View HMI)
SW501	EMOS® Early Detection Engine	SP0 11	EMOS® Monitoring additional license
SWTEM	EMOS® Single Cell Temperature Evaluato r	SWUSV	EMOS® View additional user

**ORDERING INFORMATION** 

### **ADDITIONAL INFORMATION**

EMOS® View is part of R2's Safety Software Package. Contact us for more information.



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